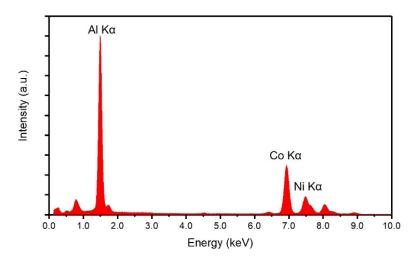


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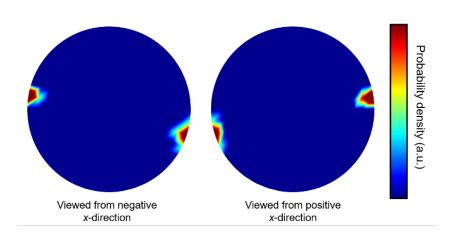
**Supporting information for article:** 

A side-by-side comparison of the solidification dynamics of quasicrystalline and approximant phases in the Al-Co-Ni system

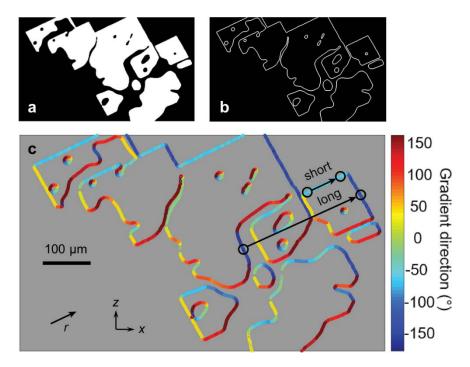
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**Figure S1** Energy dispersive spectroscopy (EDS) data collected on the as-synthesized X phase. The average atomic percent of Al, Co and Ni ratio from multiple TEM EDS measurements was  $67.4 \pm 1.7$  at%,  $24.0 \pm 1.1$  at% and  $8.7 \pm 0.8$  at%, respectively. The average EDS values correspond well with the known X phase composition, Al<sub>9</sub>(Co,Ni)<sub>4</sub>. The small peak at 8.05 keV corresponds to the Cu TEM grid.



**Figure S2** Stereographic projections of the long axes of the X phase crystals. Shown are two opposing viewpoints in the specimen frame, the negative x-direction (left) and the positive x-direction (right). The sharp peaks in both probability distributions indicate the strog degree of alignment of the crystals.



**Figure S3** Processing steps for correlation analysis. (a) Segmented image taken along the specimen x-z plane, which is nearly perpendicular to the crystallographic {010} plane of all growing X phase crystals (see also **Fig. S2**). (b) Mask image that only includes the solid-liquid interfaces of (a). (c) The orientation of each pixel belonging to the interface in (b), encoded as the direction of the image gradient (measured counter-clockwise from the positive x-axis, see colorbar). Note that opposite sides of a given crystal have orientations that differ by 180°. The arrows indicate both short-range (denoted "short") and long-range ("long") autocorrelations  $g(u, u'|\vec{r})$  of facet orientations u along the prescribed vector  $\vec{r}$ . The temperature (time) corresponds to 1213.5 K (3580 s).